



## High Common-Mode Voltage Difference Amplifier

## FEATURES

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- Common-Mode Voltage Range: ±275 V
- Minimum CMRR: 90 dB from -40°C to +125°C
- **DC Specifications:** 
  - Maximum Offset Voltage: 1100 µV
  - Maximum Offset Voltage Drift: 15 µV/°C
  - Maximum Gain Error: 0.02%
  - Maximum Gain Error Drift: 10 ppm/°C
  - Maximum Gain Nonlinearity: 0.001% FSR
- **AC Performance:** 
  - Bandwidth: 500 kHz
  - Typical Slew Rate: 5 V/µs
- Wide Supply Range: ±2.0 V to ±18 V
  - Maximum Quiescent Current: 900 µA
  - Output Swing on ±15-V Supplies: ±13.5 V
- Input Protection:
  - Common-Mode: ±500 V
  - Differential: ±500 V

## **APPLICATIONS**

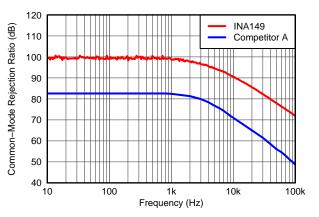
- **High-Voltage Current Sensing**
- **Battery Cell Voltage Monitoring**
- **Power-Supply Current Monitoring**
- **Motor Controls**
- Replacement for Isolation Circuits

## DESCRIPTION

The INA149 is a precision unity-gain difference amplifier with a very high input common-mode voltage range. It is a single, monolithic device that consists of a precision op amp and an integrated thinfilm resistor network. The INA149 can accurately measure small differential voltages in the presence of common-mode signals up to ±275 V. The INA149 inputs are protected from momentary common-mode or differential overloads of up to 500 V.

In many applications, where galvanic isolation in not required, the INA149 can replace isolation amplifiers. This ability can eliminate costly isolated input side power supplies and the associated ripple, noise, and quiescent current. The excellent 0.0005% nonlinearity and 500-kHz bandwidth of the INA149 are superior to those of conventional isolation amplifiers.

The INA149 is pin-compatible with the INA117 and INA148 type high common-mode voltage amplifiers and offers improved performance over both devices. The INA149 is available in the SOIC-8 package with operation specified over the extended industrial temperature range of -40°C to +125°C.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR	PACKAGE MARKING
INA149	SOIC-8	D	INA149A

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or visit the device product folder at www.ti.com.

### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Over operating free-air temperature range, unless otherwise noted.

		INA149	UNIT	
Supply voltage	(V+) – (V–)	40	V	
Input voltage range	Continuous	300	V	
Common-mode and differential, 10 s		500	V	
Maximum Voltage on $\text{REF}_{\text{A}}$ and $\text{REF}_{\text{B}}$		(V–) – 0.3 to (V+) + 0.3	V	
Input current on any input pin <sup>(2)</sup>		10	mA	
Output short-circuit current duration		Indefinite		
Operating temperature range	ge -55 to +150		°C	
Storage temperature range		-65 to +150 °C		
Junction temperature		+150	°C	
	Human body model (HBM)	1500	V	
ESD rating	Charged device model (CDM)	1000	V	
	Machine model (MM)	100	V	

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

(2) REF<sub>A</sub> and REF<sub>B</sub> are diode clamped to the power-supply rails. Signals applied to these pins that can swing more than 0.3 V beyond the supply rails should be limited to 10 mA or less.

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### ELECTRICAL CHARACTERISTICS: V+ = +15 V and V- = -15 V

At  $T_A = +25^{\circ}C$ ,  $R_L = 2 \text{ k}\Omega$  connected to ground, and  $V_{CM} = REF_A = REF_B = GND$ , unless otherwise noted.

			INA149		
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
GAIN					
Initial	V <sub>OUT</sub> = ±10.0 V		1		V/V
Gain error	V <sub>OUT</sub> = ±10.0 V		±0.005	±0.02	%FSR
Gain	vs temperature, $T_A = -40^{\circ}C$ to +125°C		±1.5	±10	ppm/°0
Nonlinearity			±0.0005	±0.001	%FSR
OFFSET VOLTAGE					
			350	1100	μV
Initial offset	vs temperature, $T_A = -40^{\circ}C$ to +125°C		3	15	µV/°C
	vs supply (PSRR), $V_S = \pm 2 V$ to $\pm 18 V$	90	120		dB
INPUT					
	Differential		800		kΩ
Impedance	Common-mode		200		kΩ
	Differential	-13.5		13.5	V
Voltage range	Common-mode	-275		275	V
	At dc, V <sub>CM</sub> = ±275 V	90	100		dB
Common-mode rejection	vs temperature, $T_A = -40^{\circ}C$ to +125°C, at dc	90			dB
(CMRR)	At ac, 500 Hz, V <sub>CM</sub> = 500 V <sub>PP</sub>	90			dB
	At ac, 1 kHz, V <sub>CM</sub> = 500 V <sub>PP</sub>		90		dB
OUTPUT					
Voltage range		-13.5		13.5	V
Short-circuit current			±25		mA
Capacitive load drive	No sustained oscillations		10		nF
OUTPUT NOISE VOLTAGE					
0.01 Hz to 10 Hz			20		μV <sub>PP</sub>
10 kHz			550		nV/√H
DYNAMIC RESPONSE	1				
Small-signal bandwidth			500		kHz
Slew rate	V <sub>OUT</sub> = ±10-V step	1.7	5		V/µs
Full-power bandwidth	$V_{OUT} = 20 V_{PP}$		32		kHz
Settling time	0.01%, V <sub>OUT</sub> = 10-V step		7		μs
POWER SUPPLY	+^				
Voltage range		±2		±18	V
	V <sub>S</sub> = ±18 V, V <sub>OUT</sub> = 0 V		810	900	μA
Quiescent current	vs temperature, $T_A = -40^{\circ}C$ to $+125^{\circ}C$			1.1	mA
TEMPERATURE RANGE					
Specified		-40		+125	°C
Operating		-55		+150	°C
Storage		-65		+150	°C

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### ELECTRICAL CHARACTERISTICS: V+ = 5 V and V- = 0 V

At  $T_A = +25^{\circ}$ C,  $R_L = 2 \text{ k}\Omega$  connected to 2.5 V, and  $V_{CM} = \text{REF}_A = \text{REF}_B = 2.5$  V, unless otherwise noted.

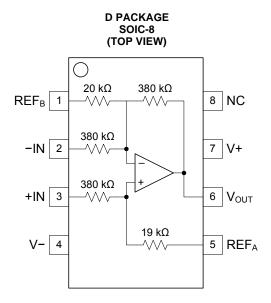
		INA149		
PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
GAIN				
Initial	V <sub>OUT</sub> = 1.5 V to 3.5 V	1		V/V
Gain error	V <sub>OUT</sub> = 1.5 V to 3.5 V	±0.005		%FSR
Gain	vs temperature, $T_A = -40^{\circ}C$ to +125°C	±1.5		ppm/°C
Nonlinearity		±0.0005		%FSR
OFFSET VOLTAGE	•		· · ·	
		350		μV
Initial offset	vs temperature, $T_A = -40^{\circ}C$ to $+125^{\circ}C$	3		μV/°C
	vs supply (PSRR), $V_S = 4 V$ to 5 V	120		dB
INPUT				
	Differential	800		kΩ
Impedance	Common-mode	200		kΩ
	Differential	1.5	3.5	V
Voltage range	Common-mode	-20	25	V
	At dc, $V_{CM} = -20$ V to 25 V	100		dB
	vs temperature, $T_A = -40^{\circ}C$ to +125°C, at dc	100		dB
Common-mode rejection	At ac, 500 Hz, V <sub>CM</sub> = 49 V <sub>PP</sub>	100		dB
	At ac, 1 kHz, V <sub>CM</sub> = 49 V <sub>PP</sub> 90			dB
OUTPUT			1	
Voltage range		1.5	3.5	V
Short-circuit current		±15		mA
Capacitive load drive	No sustained oscillations	10		nF
OUTPUT NOISE VOLTAGE			1	
0.01 Hz to 10 Hz		20		μV <sub>PP</sub>
10 kHz		550		nV/√Hz
DYNAMIC RESPONSE			ŀ	
Small-signal bandwidth		500		kHz
Slew rate	V <sub>OUT</sub> = 2 V <sub>PP</sub> step	5		V/µs
Full-power bandwidth	V <sub>OUT</sub> = 2 V <sub>PP</sub>	32		kHz
Settling time	0.01%, $V_{OUT} = 2 V_{PP}$ step	7		μs
POWER SUPPLY	+		ļ	
Voltage range		5		V
	V <sub>S</sub> = 5 V	810		μA
Quiescent current	vs temperature, $T_A = -40^{\circ}C$ to $+125^{\circ}C$	1		mA



#### THERMAL INFORMATION

		INA149	
	THERMAL METRIC <sup>(1)</sup>	D (SOIC)	UNITS
		8 PINS	
$\theta_{JA}$	Junction-to-ambient thermal resistance	110	
θ <sub>JCtop</sub>	Junction-to-case (top) thermal resistance	57	
$\theta_{JB}$	Junction-to-board thermal resistance	54	°C/W
ΨJT	Junction-to-top characterization parameter	11	°C/vv
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	53	
$\theta_{JCbot}$	Junction-to-case (bottom) thermal resistance	N/A	

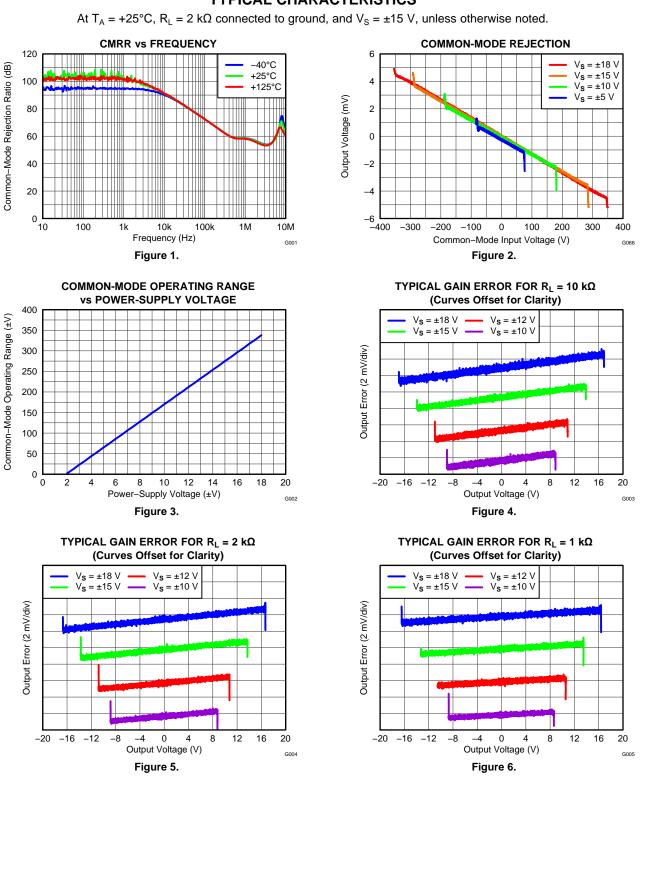
(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953. **PIN CONFIGURATION** 



#### **PIN DESCRIPTIONS**

NAME	NO.	DESCRIPTION			
–IN	2	Inverting input			
+IN	3	Ioninverting input			
NC	8	No internal connection			
REF <sub>A</sub>	5	Reference input			
REFB	1	Reference input			
V–	4	Negative power supply			
V+	7	Positive power supply <sup>(1)</sup>			
V <sub>OUT</sub>	6	Output			

(1) In this document, (V+) - (V-) is referred to as V<sub>S</sub>.



# TYPICAL CHARACTERISTICS



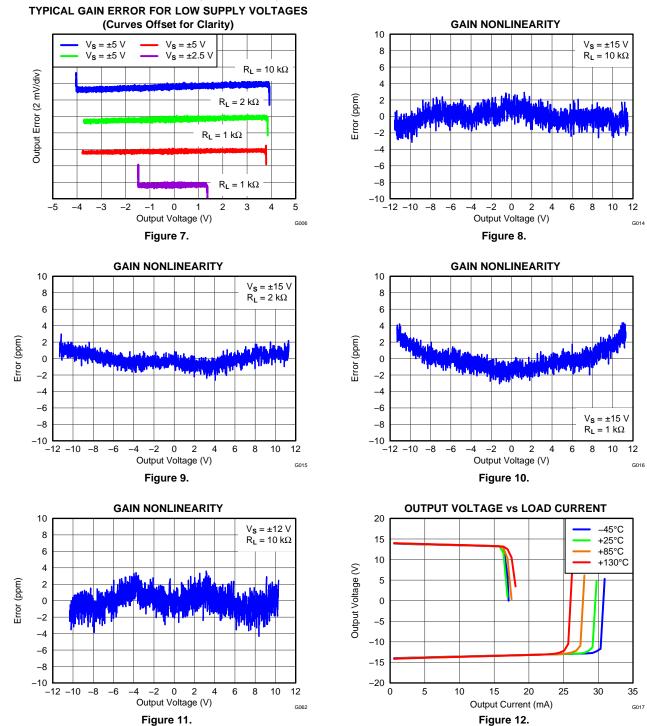
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#### **TYPICAL CHARACTERISTICS (continued)**

At  $T_A = +25^{\circ}C$ ,  $R_L = 2 \text{ k}\Omega$  connected to ground, and  $V_S = \pm 15 \text{ V}$ , unless otherwise noted.



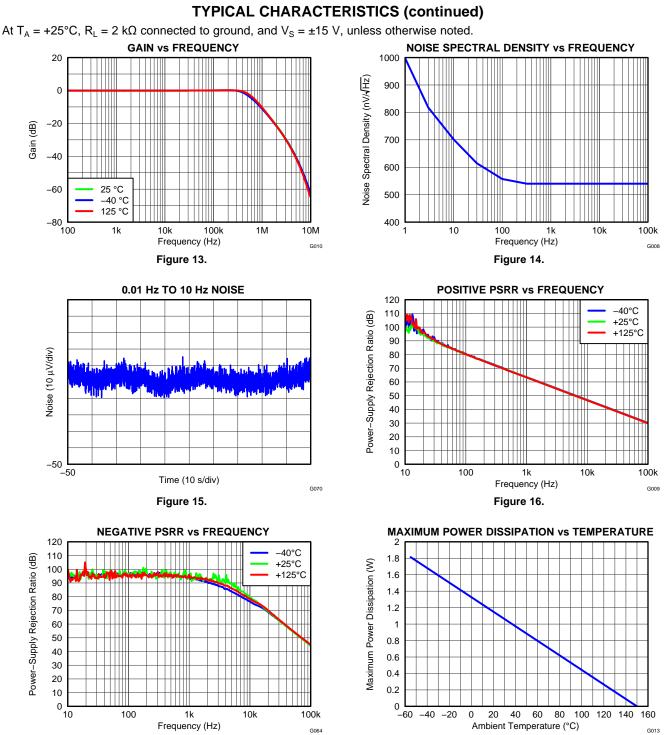


Figure 18.

Figure 17.





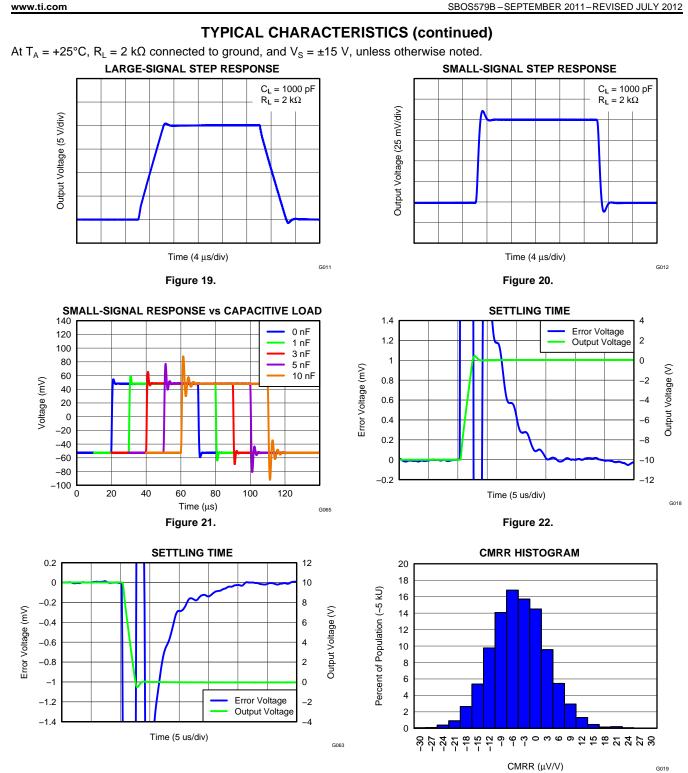
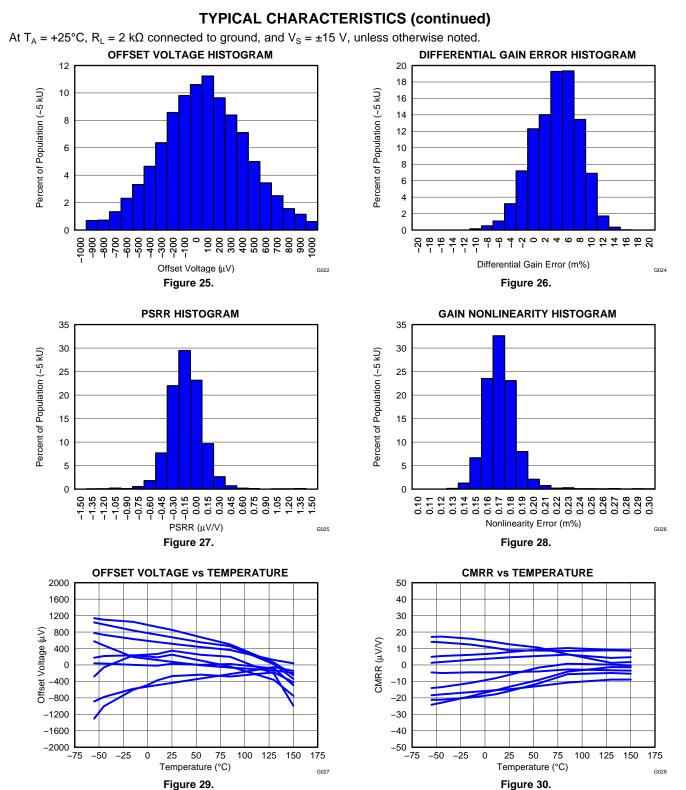
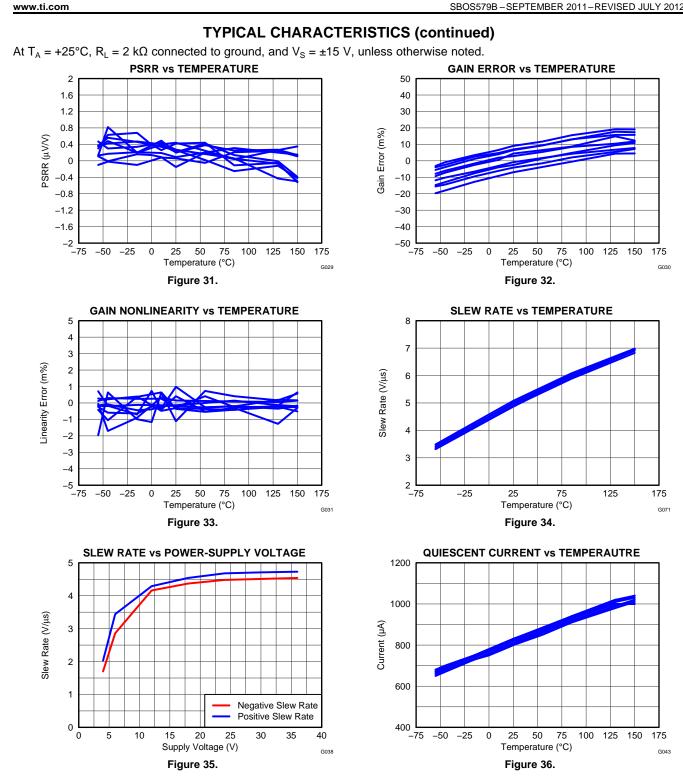


Figure 23.

Figure 24.







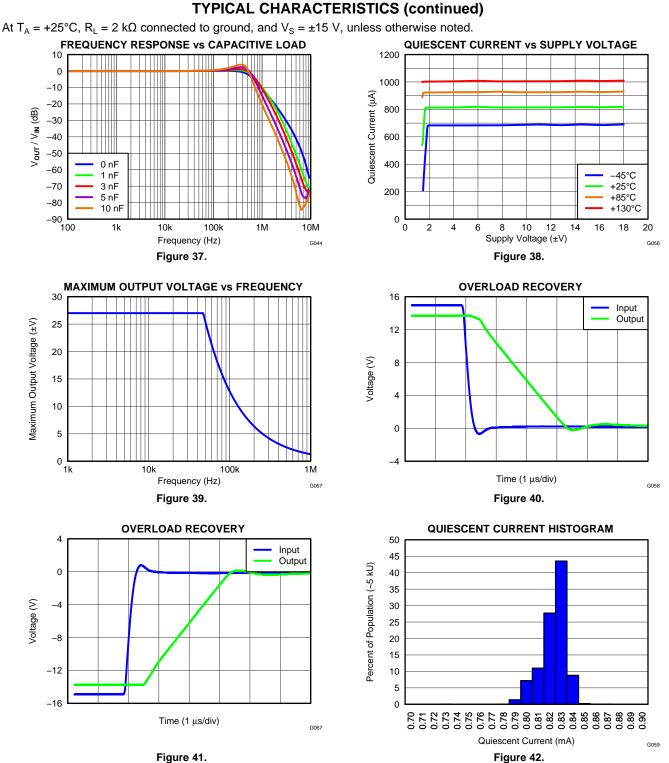


Figure 41.

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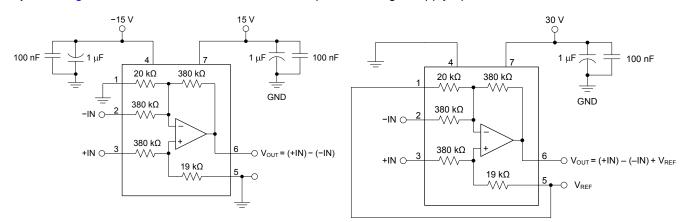
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### APPLICATION INFORMATION

#### **BASIC INFORMATION**

Figure 43 shows the basic connections required for dual-supply operation. Applications with noisy or highimpedance power-supply lines may require decoupling capacitors placed close to the device pins. The output voltage is equal to the differential input voltage between pins 2 and 3. The common-mode input voltage is rejected. Figure 44 shows the basic connections required for single-supply operation.



#### Figure 43. Basic Power and Signal Connections for Figure 44. Basic Power and Signal Connections for **Dual-Supply Operation**

Single-Supply Operation

#### **TRANSFER FUNCTION**

Most applications use the INA149 as a simple unity-gain difference amplifier. The transfer function is given in Equation 1:

$$V_{OUT} = (+IN) - (-IN)$$

(2)

Some applications, however, apply voltages to the reference terminals ( $REF_A$  and  $REF_B$ ). The complete transfer function is given in Equation 2:

 $V_{OUT} = (+IN) - (-IN) + 20 \times REF_A - 19 \times REF_B$ 

### **COMMON-MODE RANGE**

The high common-mode range of the INA149 is achieved by dividing down the input signal with a high precision resistor divider. This resistor divider brings both the positive input and the negative input within the input range of the internal operational amplifier. This input range depends on the supply voltage of the INA149.

Both Figure 2 and Figure 3 can be used to determine the maximum common-mode range for a specific supply voltage. The maximum common-mode range can also be calculated by ensuring that both the positive and the negative input of the internal amplifier are within 1.5 V of the supply voltage.

In case the voltage at the inputs of the internal amplifier exceeds the supply voltage, the internal ESD diodes start conducting current. This current must be limited to 10 mA to make sure not to exceed the absolute maximum ratings for the device.

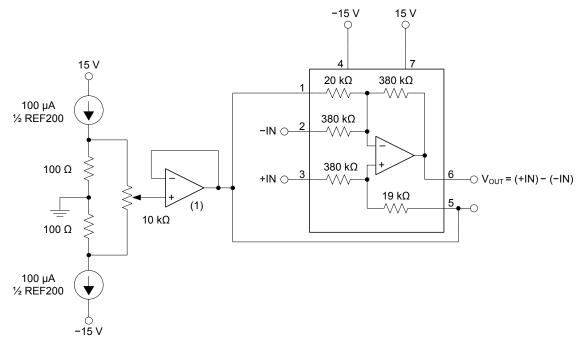


#### **COMMON-MODE REJECTION**

Common-mode rejection (CMR) of the INA149 depends on the input resistor network, which is laser-trimmed for accurate ratio matching. To maintain high CMR, it is important to have low source impedance driving the two inputs. A 75- $\Omega$  resistance in series with pins 2 or 3 decreases the common-mode rejection ratio (CMRR) from 100 dB (typical) to 74 dB.

Resistance in series with the reference pins also degrades CMR. A 4- $\Omega$  resistance in series with pins 1 or 5 decreases CMRR from 100 dB to 74 dB.

Most applications do not require trimming. Figure 45 shows an optional circuit that may be used for trimming offset voltage and common-mode rejection.



(1) The OPA171 (a 36-V, low-power, RRO, general-purpose operational amplifier) can be used for this application.

Figure 45. Offset Voltage Trim Circuit



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#### **MEASURING CURRENT**

The INA149 can be used to measure a current by sensing the voltage drop across a series resistor,  $R_s$ . Figure 46 shows the INA149 used to measure the supply currents of a device under test.

The sense resistor imbalances the input resistor matching of the INA149, thus degrading its CMR. Also, the input impedance of the INA149 loads  $R_S$ , causing gain error in the voltage-to-current conversion. Both of these errors can be easily corrected.

The CMR error can be corrected with the addition of a compensation resistor ( $R_c$ ), equal to the value of  $R_s$ , as shown in Figure 46. If  $R_s$  is less than 5  $\Omega$ , degradation in the CMR is negligible and  $R_c$  can be omitted. If  $R_s$  is larger than approximately 1 k $\Omega$ , trimming  $R_c$  may be required to achive greater than 90-dB CMR. This error is caused by the INA149 input impedance mismatch.

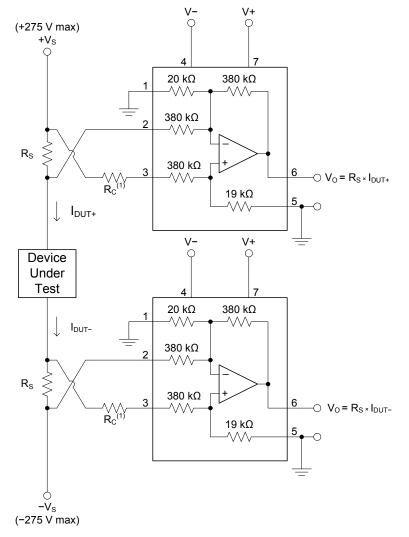


Figure 46. Measuring Supply Currents of a Device Under Test

If  $R_S$  is more than approximately 50  $\Omega$ , the gain error is greater than the 0.02% specification of the INA149. This gain error can be corrected by slightly increasing the value of  $R_S$ . The corrected value ( $R_S$ ) can be calculated by  $R_S' = R_S \times 380 \text{ k}\Omega/(380 \text{ k}\Omega - R_S)$  (3)

**Example**: For a 1-V/mA transfer function, the nominal, uncorrected value for  $R_S$  would be 1 k $\Omega$ . A slightly larger value ( $R_S' = 1002.6 \Omega$ ), compensates for the gain error as a result of loading.

The 380-k $\Omega$  term in the equation for R<sub>S</sub>' has a tolerance of 25%, thus sense resistors above approximately 400  $\Omega$  may require trimming to achive gain accuracy better than 0.02%.

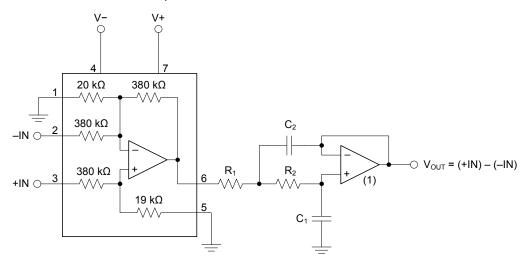
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### NOISE PERFORMANCE

The wideband noise performane of the INA149 is dominated by the internal resistor network. The thermal or *Johnson noise* of these resistors measures approximately 550 nV/ $\sqrt{Hz}$ . The internal op amp contributes virtually no excess noise at frequencies above 100 Hz.

Many applications may be satisfied with less than the full 500-kHz bandwidth of the INA149. In these cases, the noise can be reduced with a low-pass filter on the output. The two-pole filter shown in Figure 47 limits bandwidth and reduces noise. Because the INA149 has a 1/f noise corner frequency of approximately 100 Hz, a cutoff frequency below 100 Hz does not further reduce noise.

Component values for different filter frequencies are shown in Table 1.



(1) For most applications, the OPA171 can be used as an operational amplifier. For directly driving successive-approximation register (SAR) data converters, the OPA140 is a good choice.

#### Figure 47. Output Filter for Noise Reduction

BUTTERWORTH LOW-PASS (f <sub>-3 dB</sub> )	OUTPUT NOISE (mV <sub>PP</sub> )	R <sub>1</sub>	R <sub>2</sub>	C <sub>1</sub>	C <sub>2</sub>
200 kHz	1.8		No	filter	
100 kHz	1.1	11 kΩ	11.3 kΩ	100 pF	200 pF
10 kHz	0.35	11 kΩ	11.3 kΩ	1 nF	2 nF
1 kHz	0.11	11 kΩ	11.3 kΩ	10 nF	20 nF
100 Hz	0.05	11 kΩ	11.3 kΩ	0.1 µF	0.2 µF

#### Table 1. Components Values for Different Filter Bandwidths

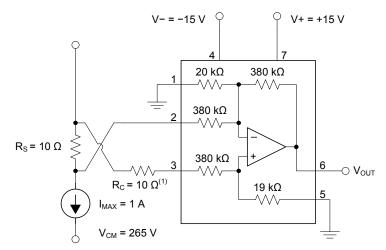


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#### ERROR BUDGET ANALYSIS

The following error budget analysis demonstrates the importance of a high common-mode rejection ratio when measuring small differential signals in the presence of high common-mode voltages. Figure 48 shows a typical current measurement application.



(1) See the *Measuring Current* section for details about  $R_C$ .

#### Figure 48. Typical Current Measurement Application

The maximum current through the shunt resistor ( $R_S$ ) is 1 A and generates a full-scale voltage drop of 10 V. All error sources in this calculation are shown in relation to this full-scale voltage. The common-mode voltage in this scenario is 265 V and the temperature range is from room temperature (+25°C) to +85°C. Table 2 shows the dominant error sources for the INA149 and a competitor device.

ERROR			ERROR (ppm of FS)		
SOURCE	INA149	COMPETIOR A	INA149	COMPETITOR A	
Accuracy, $T_A = +25^{\circ}$	c				
Initial gain error	0.02% FS	0.05% FS	200	500	
Offset voltage	1100 µV	1000 µV	110	100	
Common mode	265 V/90 dB = 8380 µV	265 V/77 dB = 37432 μV	838	3743	
		Total acuracy error	1148	4343	
Temperature drift					
Gain	10 ppm/°C × 60°C	10 ppm/°C × 60°C	600	600	
Offset voltage	10 μV/°C × 60°C	20 μV/°C × 60°C	60	120	
•		Total drift error	660	720	
		Total error	1808	5063	

If a smaller shunt resistor is used, the full-scale voltage drop is also smaller. A shunt resistor of 1  $\Omega$  causes a 1-V voltage drop with a current of 1 A flowing through it. The error of 1808 ppm for a full-scale voltage of 10 V becomes 18080 ppm (1.6%) for a full-scale voltage of only 1 V.

This example demonstrates that the dominate source of error, even over temperature, comes from the CMRR specification of the devices. The common-mode error is 46% of the total error for the INA149 and 74% of the total error for the competitor device.

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### **BATTERY CELL VOLTAGE MONITOR**

The INA149 can be used to measure the voltages of single cells in a stacked battery pack. Figure 49 shows an examples for such an application.

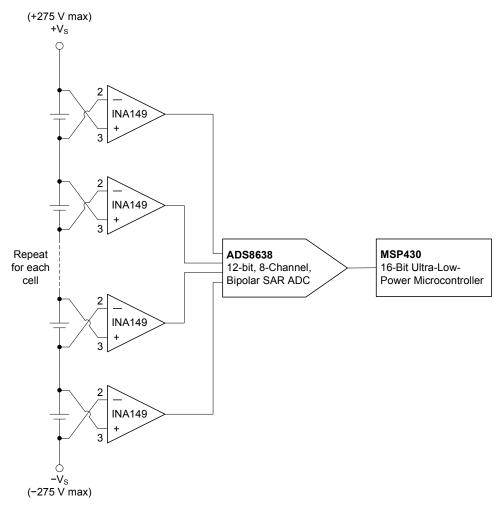


Figure 49. Battery Cell Voltage Monitor



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### **REVISION HISTORY**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	nanges from Revision A (November 2011) to Revision B	Page
•	Changed package marking data in Package/Ordering Information table	2



### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/ Ball Finish	MSL Peak Temp <sup>(3)</sup>	Samples (Requires Login)
INA149AID	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	
INA149AIDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF INA149 :

Enhanced Product: INA149-EP

## **PACKAGE OPTION ADDENDUM**



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10-Jul-2012

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

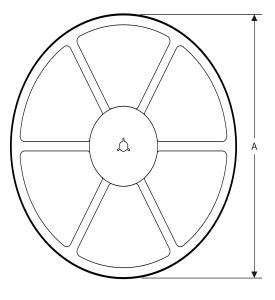
## PACKAGE MATERIALS INFORMATION

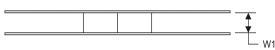
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### TAPE AND REEL INFORMATION

#### REEL DIMENSIONS

Texas Instruments





#### TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## TAPE AND REEL INFORMATION

\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins		Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA149AIDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TEXAS INSTRUMENTS

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## PACKAGE MATERIALS INFORMATION

14-Jul-2012



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA149AIDR	SOIC	D	8	2500	367.0	367.0	35.0

D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AA.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
  E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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